

Trace Elemental Analysis Educational Week

Are you new to trace elemental analysis or in need of refreshing your knowledge? Then join our European application specialists for a week of educational presentations about trace element analysis theory and practice, plus tips and tricks to help you get the most out of your instruments. Each session lasts 45 minutes, followed by 15 minutes of interactive Q&A.

The presentations will not be vendor specific and will be relevant regardless of which trace elemental analysis instruments you use in your laboratory.

All sessions will start at 2:00 pm BST each day, commencing on Monday 20th of July

Agenda		
20 th July	Trace Elemental Analysis: A guide to sample preparation and measurement	Claudia Charko
21 st July	Separation and detection: Fundamentals of ICP-OES and ICP-MS instruments	Matthew Gregory
22 nd July	ICP-MS: Comparison of single quadrupole, triple quadrupole and high resolution technology	Dr Dhinesh Asogan
23 rd July	Getting the elemental information you need: Liquid, solid and chromatographic sample introduction options	Dr Niel Williams
24 th July	How to keep your instrument healthy: ICP-OES / ICP-MS troubleshooting, useful tips and maintenance	James Hannan

To book your place, please use the link below and select the sessions you would like to attend. All attendees will be presented with certificates of attendance.

Register here

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